SCAS016A - D2957, JUNE 1987 - REVISED APRIL 1993

- Inputs Are TTL-Voltage Compatible
- Flow-Through Architecture to Optimize PCB Layout
- Center-Pin V<sub>CC</sub> and GND Configurations to Minimize High-Speed Switching Noise
- EPIC™ (Enhanced-Performance Implanted CMOS) 1-μm Process
- 500-mA Typical Latch-Up Immunity at 125°C
- Package Options Include Plastic Small-Outline Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs

### description

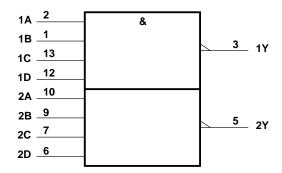
These devices contain two independent 4-input NAND gates. They perform the Boolean functions  $Y = \overline{A} \cdot B \cdot C \cdot D$  or  $Y = \overline{A} + \overline{B} + \overline{C} + \overline{D}$  in positive logic.

The 54ACT11020 is characterized for operation over the full military temperature range of  $-55^{\circ}$ C to 125°C. The 74ACT11020 is characterized for operation from  $-40^{\circ}$ C to 85°C.

# FUNCTION TABLE (each gate)

	INP	OUTPUT		
Α	В	С	D	Y
Н	Н	Н	Н	L
L	Χ	Χ	X	Н
X	L	Χ	Х	Н
X	Χ	L	Χ	Н
Х	Χ	Χ	L	Н

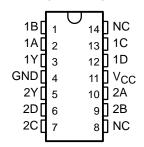
## logic symbol†



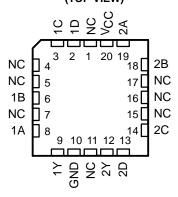
<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the D, J, and N packages.

#### 54ACT11020 ... J PACKAGE 74ACT11020 ... D OR N PACKAGE (TOP VIEW)

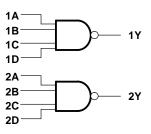


# 54ACT11020 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

## logic diagram (positive logic)



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# absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

#### recommended operating conditions

		54ACT11020		74ACT	шит	
		MIN	MAX	MIN	MAX	UNIT
VCC	Supply voltage	4.5	5.5	4.5	5.5	V
٧ıH	High-level input voltage	2		2		V
$V_{IL}$	Low-level input voltage		0.8		0.8	V
٧ <sub>I</sub>	Input voltage	0	Vcc	0	Vcc	V
۷o	Output voltage	0	Vcc	0	Vcc	V
IOH	High-level output current		-24		-24	mA
loL	Low-level output current		24		24	mA
Δt/Δν	Input transition rise or fall rate	0	10	0	10	ns/V
TA	Operating free-air temperature	-55	125	- 40	85	°C

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETER	TEST CONDITIONS	V	T <sub>A</sub> = 25°C			54ACT11020		74ACT11020		UNIT	
PARAMETER		vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT	
VOH	ΙΟΗ = – 50 μΑ	4.5 V	4.4			4.4		4.4		V	
		5.5 V	5.4			5.4		5.4			
	I <sub>OH</sub> = - 24 mA	4.5 V	3.94			3.7		3.8			
		5.5 V	4.94			4.7		4.8			
	$I_{OH} = -50 \text{ mA}^{\ddagger}$	5.5 V				3.85					
	$I_{OH} = -75 \text{ mA}^{\ddagger}$	5.5 V						3.85			
	I <sub>OL</sub> = 50 μA	4.5 V			0.1		0.1		0.1	V	
		5.5 V			0.1		0.1		0.1		
VOL	I <sub>OL</sub> = 24 mA	4.5 V			0.36		0.5		0.44		
VOL		5.5 V			0.36		0.5		0.44		
	$I_{OL} = 50 \text{ mA}^{\ddagger}$	5.5 V					1.65				
	$I_{OL} = 75 \text{ mA}^{\ddagger}$	5.5 V							1.65		
lį	$V_I = V_{CC}$ or GND	5.5 V			± 0.1		± 1		± 1	μΑ	
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			4		80		40	μΑ	
ΔICC§	One input at 3.4 V, Other inputs at GND or V <sub>CC</sub>	5.5 V			0.9		1		1	mA	
C <sub>i</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND	5 V		3.5						pF	

<sup>&</sup>lt;sup>‡</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

<sup>§</sup> This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or VCC.



<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

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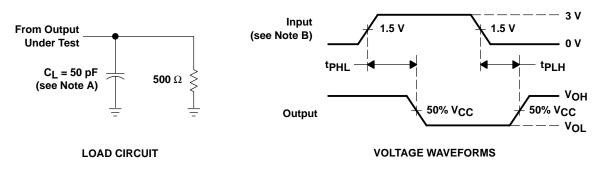
# switching characteristics over recommended ranges of supply voltage and free-air temperature (unless otherwise noted) (see Figure 1)

PARAMETER	FROM TO (OUTPUT)	то	TO T <sub>A</sub> = 25°C		;	54ACT11020		74ACT11020		UNIT
		(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	CIVIT
<sup>t</sup> PLH	Any	Y	1.5	5.6	8.5	1.5	9.5	1.5	9.1	
<sup>t</sup> PHL			1.5	6.1	8.4	1.5	9.8	1.5	9.2	ns

# operating characteristics, $V_{CC} = 5 \text{ V}$ , $T_A = 25^{\circ}\text{C}$

PARAMETER		TEST CONDITIONS	TYP	UNIT
C <sub>pd</sub>	Power dissipation capacitance per gate	$C_L = 50 \text{ pF}, \qquad f = 1 \text{ MHz}$	27	pF

## PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>I</sub> includes probe and jig capacitance.

- B. Input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_0 = 50 \Omega$ ,  $t_f = 3 \text{ ns}$ ,  $t_f = 3 \text{ ns}$ .
- C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

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